## Application/Control No. Applicant(s)/Patent Under Reexamination 10/782,819 KIM, HAHKKYU Notice of References Cited Examiner Art Unit Page 1 of 1 Chen-Wen Jiang 3744 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-US-В US-С

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name ·	Classification
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## **NON-PATENT DOCUMENTS**

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